Search Notes

Application/Control No	App	licatio	on/Con	trol No
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Applicant(s)/Patent under Reexamination

10/700,466

OHMI, TADAHIRO
Art Unit

2811

Examiner

Thien F. Tran

SEARCHED				
Class	Subclass	Date	Examiner	
257	347,374,4 10,411,50 1,506,510	4/2/2006	īπ	
257	325	4/2/2006	π	
Above	updated	11/9/2006	π	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEAF	NOTES RCH STRATEG	Y)
	DATE	EXMR
Search history printout	11/9/2006	π